MOSFET - Single N-Channel 60 V, 3.9 mΩ, 103 A

NTTFS3D7N06HL

Features

- Max $R_{DS(on)} = 3.9 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 23 \text{ A}$
- Max $R_{DS(on)} = 5.2 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 18 \text{ A}$
- High Performance Technology for Extremely Low R_{DS(on)}
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Typical Applications

- DC-DC Buck Converters
- Point of Load
- High Efficiency Load Switch and Low Side Switching
- Oring FET

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parar	neter		Symbol	Value	Unit
Drain-to-Source Voltage		V _{DSS}	60	V	
Gate-to-Source Voltag	е		V _{GS}	±20	V
Continuous Drain Current R _{θJC} (Note 1)	Steady	T _C = 25°C	Ι _D	103	Α
Power Dissipation $R_{\theta JC}$ (Note 1)	State		P _D	83	W
$\begin{array}{c} \text{Continuous Drain} \\ \text{Current R}_{\theta JA} \\ \text{(Notes 1, 2)} \end{array}$	Steady State	T _A = 25°C	Ι _D	16	Α
Power Dissipation R _{θJA} (Notes 1, 2)	Oldic		P _D	2.2	W
Pulsed Drain Current	$T_A = 25$	$T_A = 25^{\circ}C, t_p = 10 \mu s$		658	Α
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C	
Source Current (Body Diode)		I _S	69	Α	
Single Pulse Drain-to-Source Avalanche Energy (I _{AV} = 40 A, L = 0.1 mH) (Note 3)		E _{AS}	80	mJ	
Lead Temperature Soldering Reflow for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 1)	$R_{\theta JC}$	1.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	54.8	

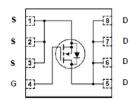
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using 1 in² pad size, 1 oz. Cu pad.
- 3. E_{AS} of 80 mJ is based on started T_J = 25°C, I_{AS} = 40 A, V_{DD} = 60 V, V_{GS} = 10 V. 100% test at I_{AS} = 40 A.



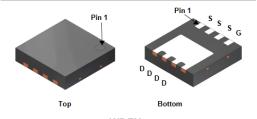
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
60 V	3.9 m Ω @ 10 V	103 A	
60 V	5.2 mΩ @ 4.5 V	103 A	



N-CHANNEL MOSFET



WDFN8 3.3X3.3, 0.65P CASE 483AW

MARKING DIAGRAM



S3D7 = Specific Device Code = Assembly Plant Code = Numeric Year Code WW = Work Week Code = Assembly Lot Code

ORDERING INFORMATION

Device	Package	Shipping†	
NTTFS3D7N06HLTWG	WDFN8 (Pb-Free)	3000 / Tape & Reel	

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	250 μΑ	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = 250 μA, ref to 25°C			38.84		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$,	T _J = 25°C			10	μΑ
		V _{DS} = 60 V	T _J = 125°C			100	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	= 20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 120 μA	1.2		2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J	I _D = 120 μA, ref	to 25°C		-4.83		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D	= 23 A		3.2	3.9	mΩ
		V _{GS} = 4.5 V, I _C	₀ = 18 A		4.1	5.2	1
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _D	= 23 A		170		S
Gate-Resistance	R_{G}	T _A = 25°	С		1		Ω
CHARGES & CAPACITANCES	•						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 30 V			2383		pF
Output Capacitance	C _{OSS}	1			400		1
Reverse Transfer Capacitance	C _{RSS}	1			11.7		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V, I _D = 11.5 A			32.7		nC
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48$	V, I _D = 11.5 A		15.1		nC
Gate-to-Source Charge	Q _{GS}	1			5.5		
Gate-to-Drain Charge	Q_{GD}				3.3		1
Plateau Voltage	V_{GP}				2.5		V
SWITCHING CHARACTERISTICS (Note 4	1)				•		•
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 4.5 \text{ V}, V_{DS}$	_S = 48 V,		15.6		ns
Rise Time	t _r	I _D = 11.5 A, R _G	= 2.5 Ω		8.4		1
Turn-Off Delay Time	t _{d(OFF)}	1			24.3		
Fall Time	t _f				6.2		
DRAIN-SOURCE DIODE CHARACTERIS	TICS	•			•		
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V$,	T _J = 25°C		0.8	1.2	V
		I _S = 23 A	T _J = 125°C		0.7		
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 11.5 \text{ A}$			39		ns
Reverse Recovery Charge	Q _{RR}				28		nC
Charge Time	ta	$V_{GS} = 0 \text{ V, dl}_S/\text{dt} = 100 \text{ A/}\mu\text{s,} \\ I_S = 11.5 \text{ A}$			21		ns
Discharge Time	t _b				16		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Switching characteristics are independent of operating junction temperatures

5. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

TYPICAL CHARACTERISTICS

 $R_{\mathrm{DS}(\mathrm{on})},$ DRAIN-TO-SOURCE RESISTANCE (m Ω)

22

 $V_{DS} = 5 V$

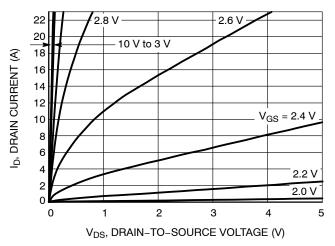


Figure 1. On-Region Characteristics

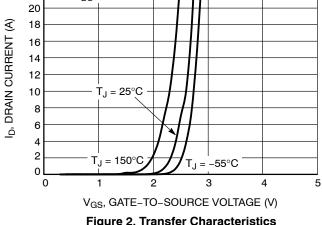


Figure 2. Transfer Characteristics

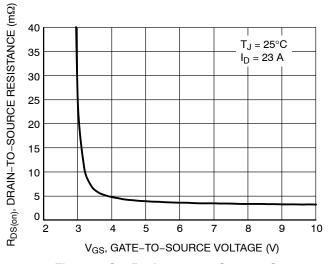


Figure 3. On-Resistance vs. Gate-to-Source Voltage

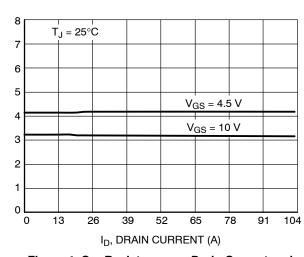


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**

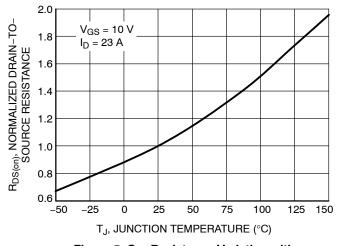


Figure 5. On-Resistance Variation with **Temperature**

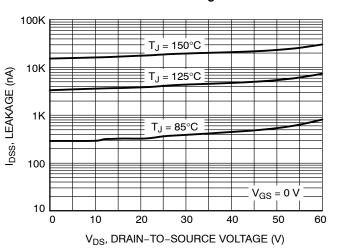


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

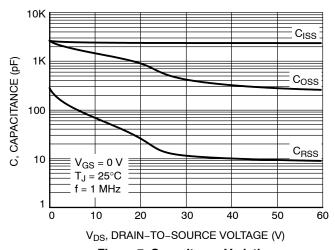


Figure 7. Capacitance Variation

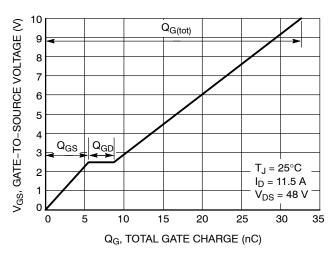


Figure 8. Gate-to-Source Voltage vs. Total Charge

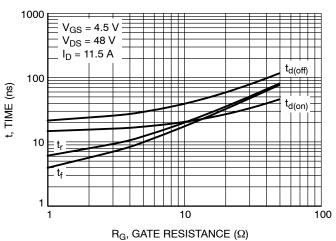


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

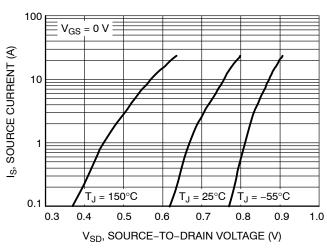


Figure 10. Diode Forward Voltage vs. Current

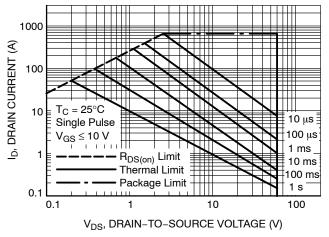


Figure 11. Maximum Rated Forward Biased Safe Operating Area

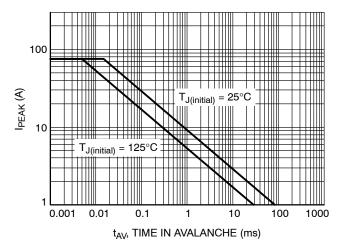


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

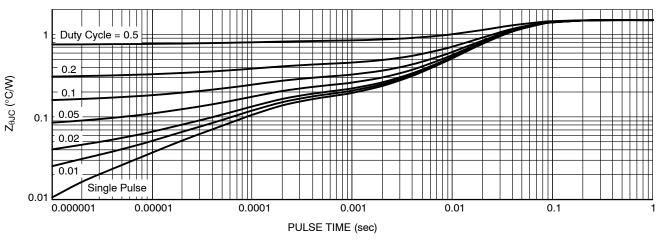


Figure 13. Transient Thermal Impedance



Α

5

TOP VIEW

В



TERMINAL #1

INDEX AREA

(D/2 X E/2)

☐ aaa C

WDFN8 3.30x3.30x0.75, 0.65P CASE 483AW ISSUE B

DATE 22 MAR 2024

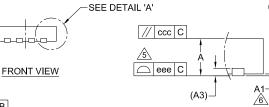
NOTES:

C

SEATING

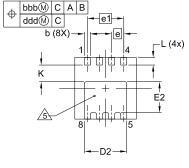
PLANE

- 1. DIMENSIONING AND TOLERANCING CONFORM TO ASME Y14.5-2018.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- THE TERMINAL #1 IDENTIFIER AND TERMINAL NUMBERING CONVENTION SHALL CONFORM TO JEP95 SEC. 3 SPP-12. DETAILS OF TERMINAL #1 IDENTIFIER ARE OPTIONAL, BUT MUST BE LOCATED WITHIN THE ZONE INDICATED. THE TERMINAL #1 IDENTIFIER MAY BE EITHER A MOLD, EMBEDDED METAL OR MARKED FEATURE.
- COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- SEATING PLANE IS DEFINED BY THE TERMINALS. 'A1' IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.



aaa C

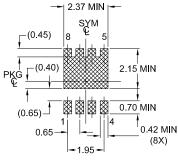
2X



BOTTOM VIEW

LAND PATTERN RECOMMENDATION

DETAIL A



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

DIM	MILLIMETERS				
Diivi	MIN NOM		MAX		
Α	0.70	0.75	0.80		
A1			0.05		
А3		0.20 REF	=		
b	0.27	0.32	0.37		
D	;	3.30 BSC	;		
D2	2.17	2.27	2.37		
Е	3.30 BSC				
E2	1.56 1.66		1.76		
е	0.65 BSC				
e1	1.95 BSC				
K	0.90				
L	0.30	0.40	0.50		
aaa	0.10				
bbb	0.10				
ccc	0.10				
ddd	0.05				
eee	0.05				

MILLIMETERS

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code A = Assembly Location

Y = Year

WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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